Spin-orbit interaction determined by antilocalization in an InSb quantum well

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The magnetoresistance at temperatures below 20 K in an *n*-InSb/In_{0.85}Al_{0.15}Sb two-dimensional electron system is studied and described in terms of antilocalization due to quantum interference under strong spin-orbit interaction. The spin-orbit interaction coefficients are extracted by fitting the magnetoresistance data to an antilocalization theory distinguishing the Rashba and Dresselhaus contributions. A good agreement between magnetoresistance data and theory suggests a Rashba coefficient $|\alpha| \approx 0.03$ eV Å and a Dresselhaus coefficient $\gamma \approx 490$ eV Å³. A strong contribution from the Dresselhaus term leads to pronounced anisotropy in the energy splitting induced by spin-orbit interaction in the two-dimensional electron dispersion.

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I. INTRODUCTION

In the study of materials where spin-dependent phenomena are prevalent, InSb stands out due to characteristics such as a strong spin-orbit interaction (SOI), a high effective gfactor, and a high electron mobility. InSb and InSb quantum wells (QWs) have drawn attention in several developments, ranging from the quest for new electronic devices,^{1,2} to magnetoresistive devices^{3,4} and spin-based electronics.⁵ Here we present low-temperature measurements of the spindependent quantum-interference effect of antilocalization (AL) in InSb quantum wells. The measurements allow a comparison with theory and a determination of the SOI parameters.

Quantum interference between partial electron waves on exact time-reversed trajectories leads to the phenomena of AL (Refs. 6–11) and weak localization (WL) (Refs. 6, 7, and 12) in low-temperature electronic transport. WL is characteristic of constructive interference of wave functions at low applied magnetic fields H, and AL of destructive interference. $^{6-12}$ The interference is governed by SOI and the phase coherence time au_{φ} , which determines the time scale available for interference. AL, in particular, can be pictured as resulting from destructive interference of spin-1/2 carriers locked onto a closed path by SOI.⁷ AL magnetotransport measurements thus form a valuable experimental tool to access SOI parameters and τ_{φ} in semiconductor systems.^{9–11,13–27} In this context, we present low-field magnetotransport measurements on an InSb two-dimensional electron system (2DES) in an InSb/In_{0.85}Al_{0.15}Sb heterostructure at temperatures T < 20 K. The observed dependence of the conductivity on H is discussed in terms of AL, and enables us to determine the dominant SOI terms, and to compare our findings with the literature on *n*-type InSb quantum wells.

SOI in (001)-grown III-V 2DESs is described by the Hamiltonian $\mathcal{H}_{S\mathcal{O}} = \hbar \boldsymbol{\sigma} \cdot \boldsymbol{\Omega}(\boldsymbol{k}),^{10,19,25-32}$ where $\boldsymbol{\sigma} = (\sigma_x, \sigma_y, \sigma_z)$ is the vector of Pauli spin matrices and \boldsymbol{k} represents the wave vector. Following Ref. 10, we introduce the wave vector in the 2DES plane, $k_p = \sqrt{k_x^2 + k_y^2}$ and θ

=tan⁻¹(k_x/k_y), where θ =0 corresponds to $k \parallel [100]$. $\Omega(k)$ is composed of a sum,

$$\mathbf{\Omega}(\mathbf{k}) = \mathbf{\Omega}^R + \mathbf{\Omega}^D_{\theta} + \mathbf{\Omega}^D_{3\theta},$$

where^{10,19,25-27,29-32}

$$\hbar \mathbf{\Omega}^{R} = \alpha k_{p} \begin{pmatrix} \sin \theta \\ -\cos \theta \end{pmatrix}, \tag{1a}$$

$$\hbar \mathbf{\Omega}_{\theta}^{D} = \gamma k_{p} \bigg(\langle k_{z}^{2} \rangle - \frac{k_{p}^{2}}{4} \bigg) \bigg(\frac{-\cos \theta}{\sin \theta} \bigg), \tag{1b}$$

$$\hbar \mathbf{\Omega}_{3\theta}^{D} = -\gamma \frac{k_{p}^{3}}{4} \left(\frac{\cos 3\theta}{\sin 3\theta} \right). \tag{1c}$$

Here α represents the Rashba coefficient, γ the Dresselhaus coefficient, and $\langle k_z^2 \rangle$ the square of the quantized wave vector in the direction perpendicular to the 2DES plane. The Rashba term, Ω^R , arises from the structural asymmetry of the heterostructure.^{10,19,25–32} The coefficient α varies with the average electric field across the well and with contributions from the interfaces between quantum well and barrier layers.^{10,25–33} Theoretical studies of asymmetric n-InSb/InAlSb quantum wells indicate that interface contributions to α dominate.²⁸ The Dresselhaus term ($\Omega^D = \Omega^D_{\theta}$ $+\Omega^{D}_{3\theta}$ arises from the lack of inversion symmetry in the zinc-blende crystal structure.³⁴ Compared to other III-V semiconductors, bulk InSb has a high value for γ_{bulk} , theoretically predicted to be in the range $560 \leq \gamma_{bulk}$ \leq 760 eV Å.^{28,35,36} Therefore, Ω^{D} may show a substantial impact on AL in InSb-based systems, and in turn AL can provide experimental insight in Ω^D and provide values for γ .

II. EXPERIMENT

The InSb 2DES studied in this work, schematically depicted in Fig. 1, was grown by molecular-beam epitaxy on semi-insulating GaAs (001) substrate. From the substrate upward, the heterostructure consists of a 215-nm-thick AlSb

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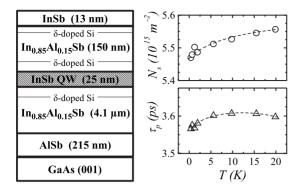


FIG. 1. Left: Schematic of the InSb/InAlSb 2DES heterostructure. The δ -doped layers are located at the following positions: 40 nm below, 40 nm above, and 140 nm above the quantum well (QW). Right: Measured carrier concentration N_s and momentum scattering time τ_p as a function of *T*. Dashed lines are guides to the eyes.

buffer, a 4.1-µm-thick In_{0.85}Al_{0.15}Sb layer, the 25-nm-thick InSb quantum well, a 150 nm In_{0.85}Al_{0.15}Sb layer, and a 13 nm undoped InSb cap layer. Electrons are provided to the well by two Si δ -doped layers, at 40 nm below and 40 nm above the well. A third δ -doped layer, 23 nm below the surface, passivates surface states. The strength of the Rashba term [Eq. (1a)], defined by α , depends on band parameters^{35,37} and on several sources of asymmetry in the heterostructure, and can vary substantially between heterostructures. In the present structure, Fermi-level pinning at the surface as well as the presence of two δ -doped layers above the quantum well contribute to asymmetry, and contribute to a sizable α via the large SOI in InSb. Spin-dependent mesoscopic transport experiments allowed an approximate value $\alpha \approx 0.1$ eV Å to be deduced in similar heterostructures.⁵ Measurements on *n*-InSb/InAlSb 2DESs which are remotely doped from only one side of the well have determined 0.07 $\leq |\alpha| \leq 0.14$ eV Å.^{38,39} In the sections below the AL data will be analyzed to obtain the magnitude of α in the heterostructure shown in Fig. 1.

Magnetotransport was measured using standard lowfrequency lock-in techniques between 0.4 and 20 K. The data and analysis presented here were obtained on a 100 $\times 20 \ \mu m$ Hall bar fabricated by photolithography and wet etching. Other samples fabricated from the same wafer yield similar results. Resistivity and Hall-effect measurements indicate that the electron areal density $N_s \approx 5.5 \times 10^{15} \text{ m}^{-2}$ and the electron mobility $\mu \approx 8.9 \text{ m}^2/\text{V} \text{ s}$ at 0.4 K. Hall-effect measurements do not show evidence of two-band transport and single-subband occupancy is thus assumed. The parameter $\langle k_z^2 \rangle$ for the first quantized level can be obtained from finite square-well solutions⁴⁰ while accounting for nonparabolicity in the InSb conduction band and using the respective band-edge offsets of the well and barrier materials.^{28,41,42} The calculation yields $\langle k_z^2 \rangle = 8 \times 10^{15} \text{ m}^{-2}$, the value used in the remainder of this work. Allowing for nonparabolicity, the effective mass m^* , $\langle k_z^2 \rangle$, N_s , and μ are used to calculate other transport parameters, such as the mobility scattering time τ_n and the two-dimensional diffusion constant D. From $\langle k_z^2 \rangle$ and N_s we can estimate the strength of $\mathbf{\Omega}^D$ at the Fermi energy

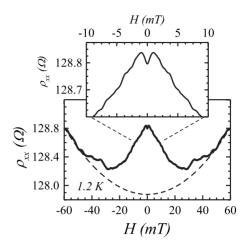


FIG. 2. Low-field changes in resistivity at T=1.2 K. The dashed line indicates the parabolic background. The inset shows positive magnetoresistance around H=0 characteristic of AL.

 E_F , using $k_F^2 = k_F^2 = 2\pi N_s$, with k_F the Fermi wave vector. For the present herostructure, the values for $\langle k_z^2 \rangle$ and N_s lead to $|[\langle k_z^2 \rangle - (\pi N_s/2)]| \ll |(\pi N_s/2)|$, and hence from Eqs. (1b) and (1c) we conclude that $|\mathbf{\Omega}_{\theta}^D| \ll |\mathbf{\Omega}_{3\theta}^D|$. Since the term $\mathbf{\Omega}_{3\theta}^D$ dominates, the term $\mathbf{\Omega}_{\theta}^D$ will be neglected in the AL analysis.

Figure 2 contains an example of the low-field magnetoresistance obtained at T=1.2 K. In order to account for slight Hall-effect contributions to the data due to inevitable contact misalignment, the component antisymmetric in H has been subtracted from the data. For $0 \le H \le 30$ mT the sample exhibits the positive magnetoresistance transitioning to negative magnetoresistance characteristic of AL. At higher $H(H \ge 30$ mT) an $\sim H^2$ dependence of the magnetoresistance is observed, typical of geometric magnetoresistance in high- μ materials,³ and is accounted for in order to ensure accuracy of the AL analysis.

AL (Refs. 6, 8–11, 19, 25, 26, and 43) is expressed as a change in longitudinal conductivity, σ_{xx} . Ignoring electronelectron interactions, the *H* dependence of σ_{xx} is contained in the sum of a classical term and the AL correction term,¹²

$$\sigma_{xx}(H) = \frac{\sigma_0}{1 + (\mu H)^2} + \Delta \sigma(H), \qquad (2)$$

where $\sigma_0 = N_s e^2 \tau_p / m^*$ denotes the zero-*H* Drude conductivity and $\Delta \sigma(H)$ the AL correction. The experiment measures the longitudinal resistivity $\rho_{xx}(H)$, and the following steps are followed to determine $\Delta \sigma(H)$ from $\rho_{xx}(H)$. First a purely quadratic term $\sim H^2$ is fit to the high-field data (Fig. 2), and the H^2 term is subtracted from the measured ρ_{xx} to determine $\Delta \rho(H)$. $\Delta \rho(H)$ denotes the AL correction to ρ_{xx} . Then $\Delta \sigma(H)$ is determined using $\Delta \sigma(H) \approx -\Delta \rho(H) \rho_0^{-2}$, where $\rho_0 \equiv \sigma_0^{-1}$.

Examples of $\Delta\sigma(H)$ are displayed in Fig. 3. The data exhibits the characteristic shape of AL, with an initial decrease in conductivity from H=0, reaching a minimum at $H=H_{\min}\approx 1.1$ mT, after which positive magnetoconductivity is observed. The $\Delta\sigma(H)$ curves are parametrized in terms of τ_p , the phase coherence time τ_{φ} , and in terms of the various contributions to $\Omega(\mathbf{k})$. Specifically, $\Delta\sigma(H)$ was fit to an

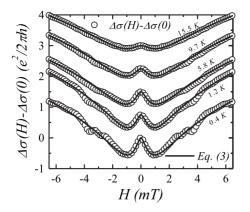


FIG. 3. Changes in conductivity derived from the data at different T, along with the fits obtained from Eq. (3). The curves have been offset for clarity.

AL expression which separately accounts for Ω^R and $\Omega^D_{3\theta}$, $\Omega^{10,26}_{2\theta}$ and which allows us to examine their respective magnitudes and dependence on *T*.

III. ANALYSIS

In 2DESs where Ω^D_{θ} can be neglected, the AL correction to the conductivity in perpendicular *H* can be expressed as^{10,26}

$$\Delta\sigma(H) = \frac{-e^2}{4\pi^2\hbar} \left[3C + \frac{1}{a_0} + \frac{2a_0 + 1 + b_s}{a_1(a_0 + b_s) - 2b'_s} - \sum_{n=1}^{\infty} \frac{3}{n} - \frac{3a_n^2 + 2b_s a_n - 1 - 2(2n+1)b'_s}{(a_n + b_s)a_{n-1}a_{n+1} - 2b'_s[(2n+1)a_n - 1]} + 2\ln(b_{tr}) + \Psi\left(\frac{1}{2} + b_{\varphi}\right) \right],$$
(3)

where Ψ represents the *digamma* function; *C* is Euler's constant; $a_n = b_{\varphi} + b_s + n + (1/2)$; $b_{Ir} = (\hbar/4eD\tau_p H)$; $b'_s = (2\hbar |\mathbf{\Omega}^R|^2 \tau_1/4eDH)$; $b_s = b'_s + (2\hbar |\mathbf{\Omega}^D_{(3\theta)}|^2 \tau_3)/4eDH$; and $b_{\varphi} = (\hbar/4eD\tau_{\varphi}H)$. The relaxation times $\tau_n(n=1,3)$ are expressed as^{10,30,44}

$$\frac{1}{\tau_n} = \int W(\zeta) [1 - \cos(n\zeta)] d\zeta, \qquad (4)$$

where $W(\zeta)$ denotes the scattering probability, dependent on the scattering angle ζ . We note that for degenerate systems $\tau_1 = \tau_p$.³¹ The value of $(\tau_1/\tau_3) = (\tau_p/\tau_3)$ in 2DESs ranges from $(\tau_1/\tau_3) = 1$ for isotropic scattering to $(\tau_1/\tau_3) = 9$ for smallangle scattering.^{10,30,44} Although Eq. (3) is derived for the diffusive regime $(b_{tr} > 1)$, previous AL experiments demonstrate that nominally diffusive formalisms accurately describe SOI in high- μ 2DES.¹⁵ Equally satisfactory fits to our experimental data were, in fact, not obtained with theories aiming beyond the diffusive regime.^{9,11}

With b_{tr} determined from N_s and ρ_0 , the experimental $\Delta\sigma(H) - \Delta\sigma(0)$ for |H| < 6.5 mT at different *T* were fit to Eq. (3), allowing us to separately assess $\mathbf{\Omega}^R$ and $\mathbf{\Omega}_{3\theta}^D$ (neglecting $\mathbf{\Omega}_{\theta}^D$). Fits to Eq. (3) were performed while varying b_s , b'_s , and

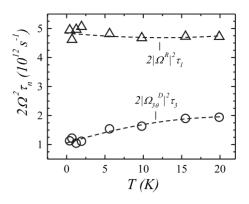


FIG. 4. The terms $2\Omega^2 \tau_n$ extracted from fits of $\Delta \sigma(H) - \Delta \sigma(0)$ to Eq. (3). From the $2\Omega^2 \tau_n$ corresponding contributions to Ω can be deduced. Dashed lines form guides to the eyes.

 b_{φ} , and the total error in the values thus obtained are estimated at ~10%. From b_s and b'_s we can deduce $2|\Omega^R|^2 \tau_1$ and $2|\Omega^D_{3\theta}|^2 \tau_3$, and hence, with knowledge of $\tau_1 = \tau_p$ and τ_3 , we obtain $|\Omega^R|$ and $|\Omega^D_{3\theta}|$. The results are presented below.

IV. RESULTS AND DISCUSSION

Examples of the fits of Eq. (3) to the experimental $\Delta\sigma(H) - \Delta\sigma(0)$ are displayed along with the corresponding data in Fig. 3. Equation (3) accurately models $\Delta \sigma(H)$ $-\Delta\sigma(0)$ at all T, with a slight deviation at an oscillatory structure occurring at $H \approx \pm 3$ mT in our data. The strong T dependence of the oscillatory structure, which becomes quite weak above ≈ 5 K, suggests a phase coherence phenomenon is responsible. Although the exact origin of the observed oscillatory structure forms the subject of future study, here we offer one possible explanation. One expects universal conduction fluctuations to be averaged out due to the size of the device. However, the heterostructure shows a low density of pyramidal structural defects (associated with threading dislocations) which are not expected to affect mobility due to their low density and extended mesoscopic size.⁴⁵ A hypothetical origin for the oscillatory magnetoresistance lies in Altshuler-Aronov-Spivak oscillations⁴⁶ occurring for electron trajectories encompassing such mesoscopic defects, as also observed in lithographic antidot lattices.⁴⁷ In the present case the irregular defect size and spacing preclude welldeveloped oscillations while still allowing for magnetoresistance effects associated with orbits of defined enclosed magnetic flux. AL phenomena do not encompass such oscillatory structure, and hence the structure is ignored for the remainder of the present work.

Figure 4 depicts the terms in Eq. (3) originating from different SOI contributions, $2|\Omega^R|^2 \tau_1$ and $2|\Omega^D_{3\theta}|^2 \tau_3$ as obtained from the fits to the data. The magnitude of $2|\Omega^R|^2 \tau_1 = 4\pi N_s \alpha^2 \hbar^{-2} \tau_p$ exceeds $2|\Omega^D_{3\theta}|^2 \tau_3 = (\pi N_s)^3 \gamma^2 \hbar^{-2} \tau_3$, indicating that Rashba SOI provides the largest contribution to $\Delta\sigma(H) - \Delta\sigma(0)$. However, accounting for the contribution from $\Omega^D_{3\theta}$ is necessary for correct modeling of $\Delta\sigma(H) - \Delta\sigma(0)$, with increased relevance at higher *T*. Moreover, as indicated below, both $\Omega^D_{3\theta}$ and Ω^R play important roles in the energy dispersion of the 2DES. We extract $|\alpha| \approx 0.03$ eV Å

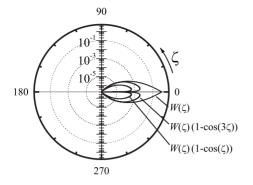


FIG. 5. Calculated angular dependence of $W(\zeta)$, $W(\zeta)[1 - \cos(\zeta)]$, and $W(\zeta)[1 - \cos(3\zeta)]$ normalized to W(0), from Eq. (5). The radial axis follows a logarithmic scale.

from the observed value of $2|\mathbf{\Omega}^R|^2 \tau_1 \approx 4.8 \times 10^{12} \text{ s}^{-1}$. This value for $|\alpha|$ lies within the expected range, and bears comparison with recent theoretical calculations predicting $|\alpha^{th}| \approx 0.04 \text{ eV} \text{ Å}$ for *n*-InSb/InAlSb 2DESs with equal barrier heights on both sides of the well.²⁸

Interpretation of $2|\Omega_{3\theta}^{D}|^{2}\tau_{3}$ requires a discussion of (τ_{1}/τ_{3}) . The ratio (τ_{1}/τ_{3}) depends on the scattering mechanism.^{10,30,44} In accordance with previous studies of electronic transport in 30-nm-wide *n*-InSb/InAlSb 2DESs with high μ ,⁴⁸ remote-ionized impurity scattering from Si ions in the δ -doped layers is expected to dominate electron scattering at low *T*. For 2DESs under remote-ionized impurity scattering, the angular dependence of $W(\zeta)$ can be approximated by^{40,48}

$$W(\zeta) \propto \frac{\exp(-2qd)}{(q+q_{TF})^2},\tag{5}$$

where the scattering wave vector $q = |2k_F \operatorname{sin}(\zeta/2)|$, and d = 40 nm denotes the distance separating the 2DES from the ionized impurities. With an effective Bohr radius $a_B = 67$ nm, the Thomas-Fermi screening wave vector $q_{TF} = (2/a_B) = 2.9 \times 10^7 \text{ m}^{-1}$. Figure 5 contains the angular dependences of $W(\zeta)$, $W(\zeta)[1 - \cos(\zeta)]$, and $W(\zeta)[1 - \cos(3\zeta)]$ normalized to W(0), in a polar graph. $W(\zeta)$ is strongly peaked toward small ζ , as expected for the predominantly small-angle scattering from remote-ionized impurities. As compared to $[1 - \cos(\zeta)]$, the multiplicative effect of the factor $[1 - \cos(3\zeta)]$ is strongest at small ζ , leading to a higher ratio (τ_1/τ_3) for small-angle scattering than for large-angle scattering.

From Eqs. (4) and (5) we calculate $(\tau_1/\tau_3) \approx 9$. From the observed $2|\Omega_{3\theta}^D|^2\tau_3 \approx 1.1 \times 10^{12} \text{ s}^{-1}$ at 0.4 K we then extract $\gamma \approx 490 \text{ eV Å}^3$. This value agrees closely with theoretical calculations yielding γ in *n*-InSb/InAlSb quantum wells as a function of well thickness, which have predicted $\gamma \approx 425 \text{ eV Å}^3$ for a 25-nm-wide well.²⁸ The value $\gamma = 490 \text{ eV Å}^3$ signifies, in fact, an upper bound for γ at 0.4 K, resulting from the assumption of dominant remote-ionized impurity scattering. Accounting for other scattering mechanisms which yield a smaller ratio (τ_1/τ_3) , such as phonon scattering or interface roughness scattering,³⁰ would result in a somewhat smaller γ . We stress however that at T=0.4 K

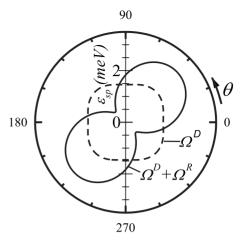


FIG. 6. Calculated SOI-induced energy splitting $\epsilon_{sp} = 2\hbar |\Omega|$ of the conduction band at $k_F(k_F^2 = 2\pi N_s)$ as a function of momentum direction. The plot is obtained by substituting $\gamma = 490$ eV Å³, $\alpha = 0.03$ eV Å, and $\langle k_{\gamma}^2 \rangle = 8 \times 10^{15}$ m⁻² into Eqs. (1a)–(1c).

remote-ionized impurity scattering, rather than phonon or interface roughness scattering, likely determines (τ_1/τ_3) and we hence accept $\gamma \approx 490$ eV Å³.

From the extracted values for $\alpha \approx 0.03$ eV Å and $\gamma = 490$ eV Å³ at 0.4 K we calculate the average spin-orbitinduced energy splitting of the conduction band at k_F as $\langle \epsilon_{sp} \rangle \approx 1.8$ meV, and an average spin-precession frequency of $2\langle |\mathbf{\Omega}| \rangle = 2.7 \times 10^{12} \text{ s}^{-1}$. The dependence of ϵ_{sp} on momentum direction, depicted in Fig. 6, reveals an anisotropy of ϵ_{sp} in the plane of the 2DES. ϵ_{sp} ranges between ≈ 0.6 and ≈ 2.8 meV depending on the direction of \mathbf{k} . The angular dependence results from the 3θ dependence of $\mathbf{\Omega}_{3\theta}^{D}$ as compared to the θ dependence of $\mathbf{\Omega}^{R}$. The fact that both terms have substantial values in the 2DES produces a marked anisotropy.

Beyond T=0.4 K, $2|\mathbf{\Omega}^R|^2 \tau_1 \sim N_s \tau_p$ is found to have a negligible *T* dependence reflecting the fact that, as observed in Hall measurements, N_s and τ_p remain almost constant (<2% change) over this range of *T*. In contrast, $2|\mathbf{\Omega}^D_{3\theta}|^2 \tau_3 \sim N_s^3 \tau_3$ increases by a factor ≈ 1.7 from 0.4 to 20 K. In order to explain the dependence on *T* of spin relaxation in III-V semiconductors, Ref. 30 has shown that $2|\mathbf{\Omega}^R|^2 \tau_1$ and $2|\mathbf{\Omega}^D_{3\theta}|^2 \tau_3$ can be multiplied by *T*-dependent factors, to become

$$|\mathbf{\Omega}^R|^2 \tau_1 \to |\mathbf{\Omega}^R|^2 \tau_p (1 - e^{-E_F \beta})^{-1}, \tag{6a}$$

$$|\mathbf{\Omega}_{3\theta}^D|^2 \tau_3 \rightarrow \frac{|\mathbf{\Omega}_{3\theta}^D|^2}{(E_F \beta)^2} \frac{\tau_p(\tau_3/\tau_1)}{1 - e^{-E_F \beta}} \frac{J_{\nu+3}(\beta \mu_0)}{J_{\nu+1}(\beta \mu_0)}, \tag{6b}$$

where $\beta = 1/k_B T$ (with k_B the Boltzmann constant), the chemical potential $\mu_0 = \ln(e^{E_F\beta} - 1)/\beta$, $4J_n(z) = \int_0^\infty x^n \operatorname{sech}^2[(x - z)/2]dx$, and where ν depends on the operational scattering mechanism. For weakly screened charged impurity scattering considered here, $\nu = 2.3^0$ Using values for $|\alpha|$ and γ obtained at 0.4 K we find that Eq. (6a) accurately describes $2|\Omega^R|^2\tau_1$ over the experimental range of *T*. However, Eq. (6b) predicts a weaker *T* dependence of $2|\Omega^R_{3\theta}|^2\tau_3$ than experimentally observed (Fig. 4). A portion of the additional *T* dependence

results from changes in (τ_3/τ_1) from increased phonon scattering with T. We suggest that electron-electron (e-e) scattering may also contribute to the observed T dependence of $2|\Omega_{3\theta}^D|^2\tau_3$. Although *e-e* scattering has little effect on τ_p , recently a large impact of *e-e* scattering on spin relaxation has been suggested in high- μ GaAs/AlGaAs quantum wells.^{49,50} As compared to doped semiconductor thin films, remotely doped heterostructures experience a much reduced scattering rate from ionized impurities, and hence effects arising from *e-e* scattering^{49,50} are more evident in high- μ 2DESs. Equation (3) does not explicitly include the contribution from e-escattering to spin relaxation, yet its effect can be approximated as follows. Since the parameter b_s expresses the spinrelaxation rate, we expect the effect of e-e scattering on spin relaxation to affect b_s . Any contribution to b_s not included in b'_s is grouped into the term $2|\Omega^D_{3\theta}|^2\tau_3$, suggesting that the spin-relaxation rate from *e-e* scattering $(1/\tau_s^{ee})$ should be added to b_s , namely, $b_s \rightarrow b_s^* = b_s + \hbar/(4eDH\tau_s^{ee})$, similar to the inclusion of spin relaxation via the Elliot-Yafet mechanism.¹⁰ Experimentally observed then is the value of $2|\mathbf{\Omega}_{3\theta}^D|^2\tau_3^*$ derived from b_s^* , with $2|\mathbf{\Omega}_{3\theta}^D|^2\tau_3^*=2|\mathbf{\Omega}_{3\theta}^D|^2\tau_3$

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+ $(1/\tau_s^{ee})$. As $T \rightarrow 0$, *e-e* scattering is expected to vanish. Thus $1/\tau_s^{ee}$ is not expected to alter the values of $|\alpha|$ and γ obtained from the 0.4 K values of $2|\mathbf{\Omega}^R|^2\tau_1$ and $2|\mathbf{\Omega}^D_{3\theta}|^2\tau_3$. Yet, our observation suggests that the *T* dependence of $2|\mathbf{\Omega}^D_{3\theta}|^2\tau_3^*$ may be a consequence of an increase in $1/\tau_s^{ee}$ with *T*, not negligible except at the lowest *T*.

In summary, we have extracted the SOI terms active in an *n*-InSb/InAlSb 2DES, by fitting magnetotransport measurements with AL theory. Accurate modeling of the measured $\Delta\sigma(H) - \Delta\sigma(0)$, requires the presence of both the Rashba SOI Ω^R and the Dresselhaus $\Omega^D_{3\theta}$ contributions, and requires an estimate of the predominant momentum scattering mechanism. It is found that in the heterostructure the Rashba coefficient $\alpha \approx 0.03$ eV Å and the Dresselhaus coefficient $\gamma \approx 490$ eV Å³.

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